## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10664571	CHEN ET AL.
Examiner	Art Unit
Mitchell, Jason	2193

SEARCHED						
Class	Subclass	Date	Examiner			
717	101-103,120-124,171-173	11/15/06	jm			

	SEARCH NOT	ES	
	Search Notes	Date	Examiner
east		. 11/15/06	jm

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Paper No. :